

Modeling, Filtering and Optimization for AFM Arrays

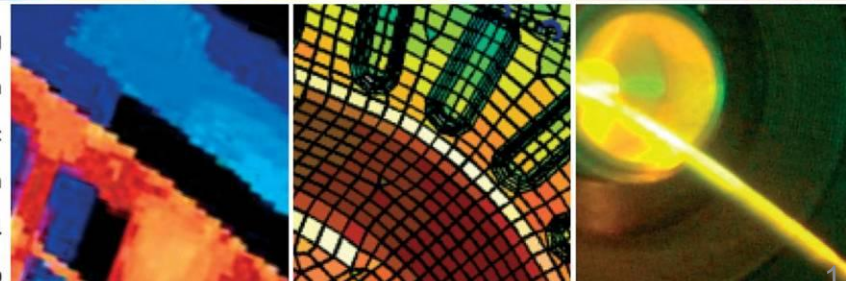
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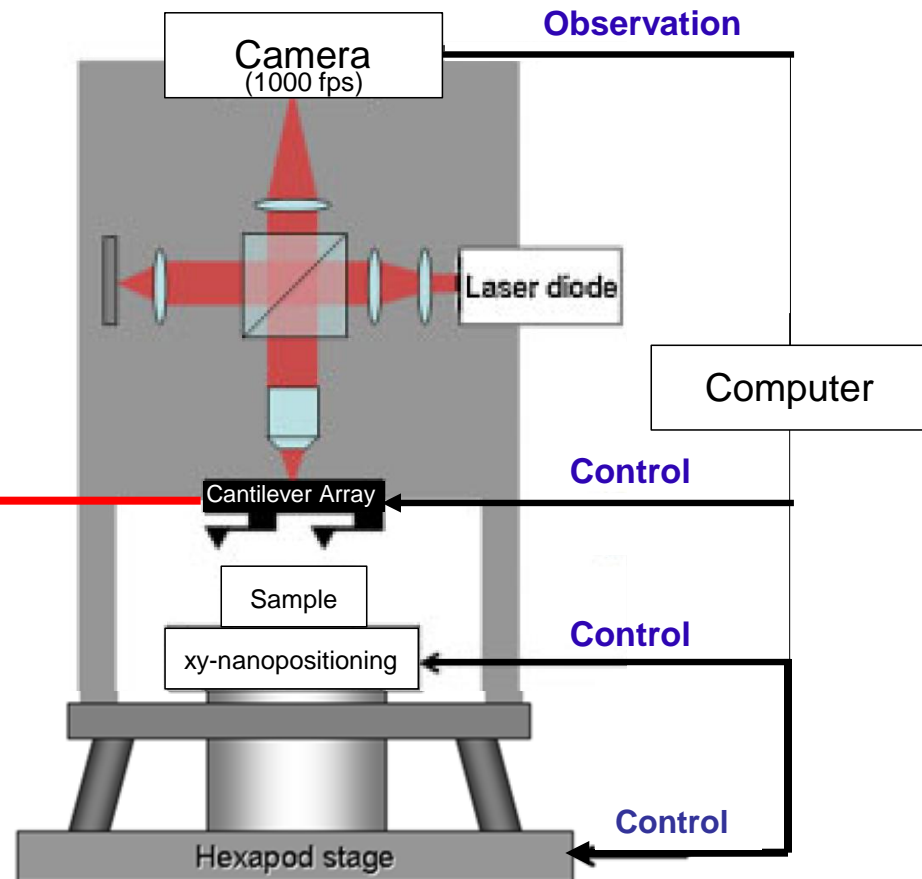
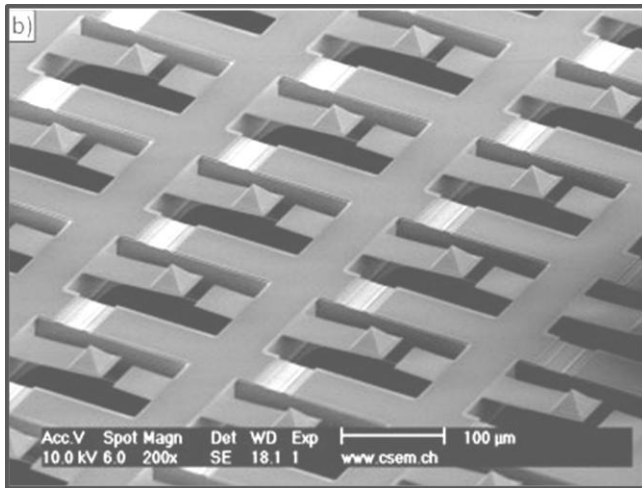
FEMTO-ST

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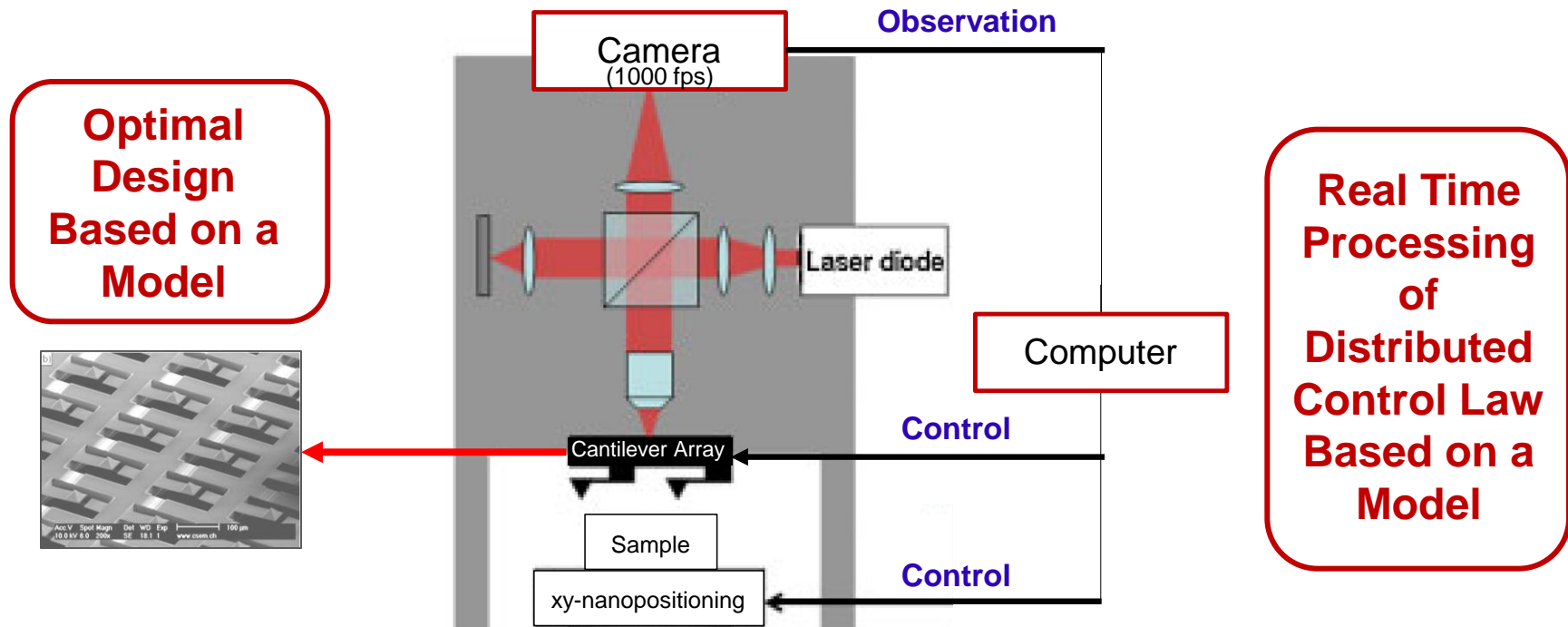
cultivating
innovation
from basic
research
to industrial
partnership





- **Design of the Array**
- **Functioning modes: Contact mode, Dynamic mode**

Real Time Interferometry Image Processing

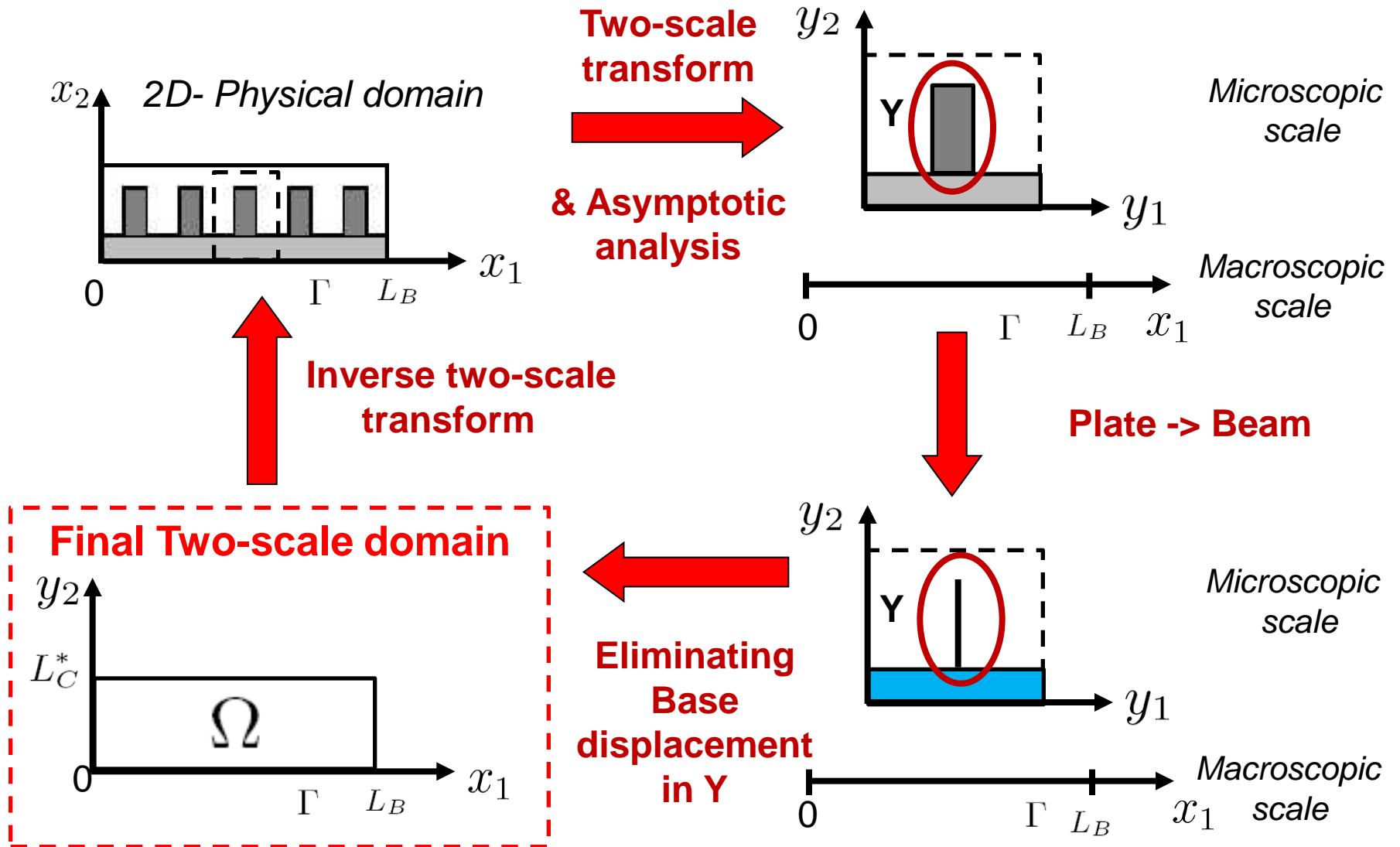


Optimal Design Based on a Model

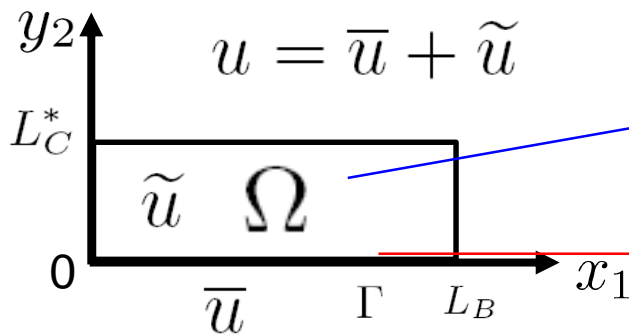
Real Time Processing of Distributed Control Law Based on a Model

- **Modeling: Two-scale Modelling**
- **Design: Robust Optimization Based on the Two-Scale Model**
- **Image Processing for Interferometry: Topographic scan**
- **Distributed Control: Semi-Decentralized**

- Two-scale Modelling (AFMALab Software)**
- Robust Parameter Optimization (SIMBAD Software)**
- Image Processing for Interferometry**
- Semi-Decentralized Distributed Control**



Final Two-scale domain



Motion equation in cantilevers at the microscale

$$m^C \partial_{tt}^2 \tilde{u} + m^C \partial_{tt}^2 \bar{u} + r^C \partial_{y_2 \dots y_2}^4 \tilde{u}$$

Motion equation in base at the macroscale

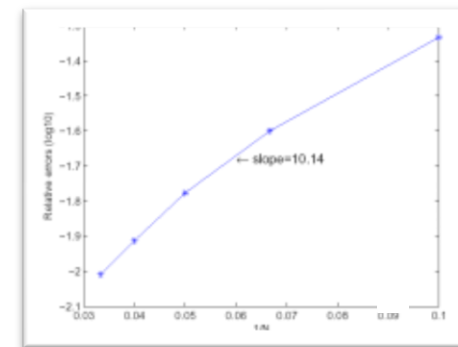
$$\rho^B \partial_{tt}^2 \bar{u} + R^B \partial_{x_1 \dots x_1}^4 \bar{u} + \ell_C r^C (\partial_{y_2 y_2 y_2}^3 \tilde{u})$$

FEM discretization of \bar{u} in Base

Modal Decomposition of \tilde{u} in the Cantilevers

$$\tilde{u}(t, x_1, y_2) \approx \sum_{k=1}^N \tilde{u}_k(t, x_1) \phi_k(y_2) \quad \text{and} \quad F^C(t, x_1, y_2) \approx \sum_{k=1}^N f_k^C(t, x_1) \phi_k(y_2)$$

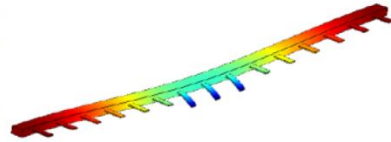
where $\{\phi_k(y_2)\}_{k=1..N}$ are the cantilever modes



L²-norm error in a logarithmic scale with respect to cell size

The One-dimensional Model

Solutions are approximated in the Multi-scale domain with respect to small thickness or large number of cells. This yields a two-scale model for a cantilever array. It is governing deflections for an infinite number of cantilevers.

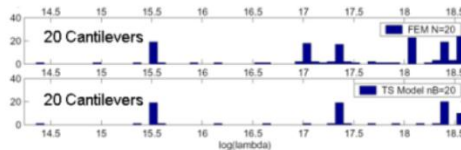


In base: $m^B \partial_{tt} u^0 + r^B \partial_{x_1 \dots x_1}^4 u^0 = -d^B \partial_{y_2 \dots y_2}^3 u^0 + f^B$

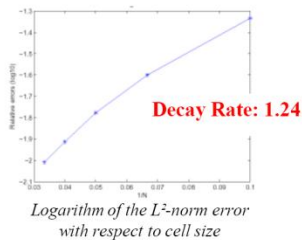
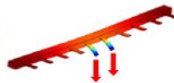
In cantilevers: $m^C \partial_{tt} u^0 + r^C \partial_{y_2 \dots y_2}^4 u^0 = f^C$

Interface: $u^0|_{cantilever} = u^0|_{base}$ and $(\partial_{y_2} u^0)|_{cantilever} = 0$

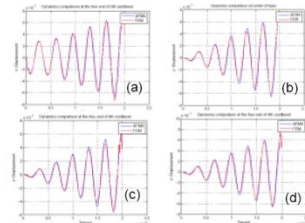
Eigenvalues:



Statics:

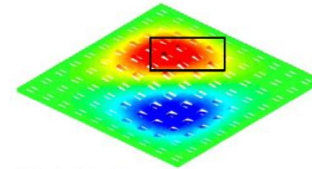


Dynamics:



Excitation: First Eigenfrequency; Displacement (a) Fifth lever end, (b) Base middle, (c) Fourth lever end, (d) Sixth lever end

The Two-Dimensional Model

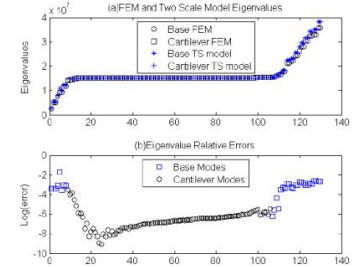
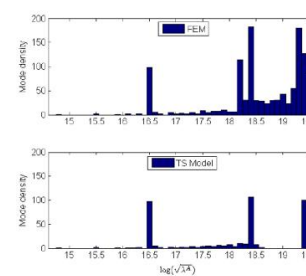


Global and local view of a Cantilever Array

Model in Base:

$$\rho^B \partial_{tt} u^A + \text{div}_{\bar{x}}(\text{div}_{\bar{x}}(R^B : \nabla_{\bar{x}} \nabla_{\bar{x}}^T u^A)) + \ell_C^0 r^C (\partial_{y_2 y_2 y_2}^3 u^A)|_{junction} = f^B$$

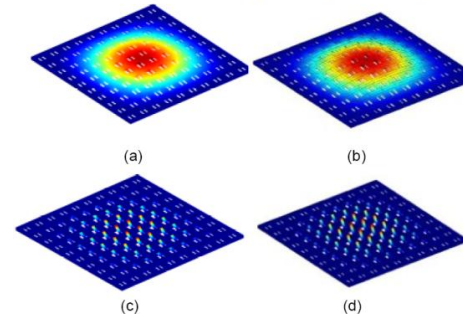
MS Model / FEM Eigenfrequency comparison:



Comparison of Eigenvalue density distributions for (a) the FEM and for (b) the MSM

(a) Superimposition of eigenvalue distributions for the FEM and for the MSM
(b) Relative errors

MS Model / FEM Eigenshapes comparison:



First base eigenmode shape
(a) Multi-scale Model
(b) FEM

First cantilever eigenmode shape
(c) Multi-scale Model
(d) FEM

- ❑ **Two-scale Modelling (AFMALab Software)**
- ❑ **Robust Parameter Optimization (SIMBAD Software)**
- ❑ **Image Processing for Interferometry**
- ❑ **Semi-Decentralized Distributed Control**

Sensitivity Analysis: Selection of design variables with the greatest impact

Deterministic Design Optimization: Optimization of design variables with constraints

Uncertainty quantification: Impact of manufacturing uncertainties

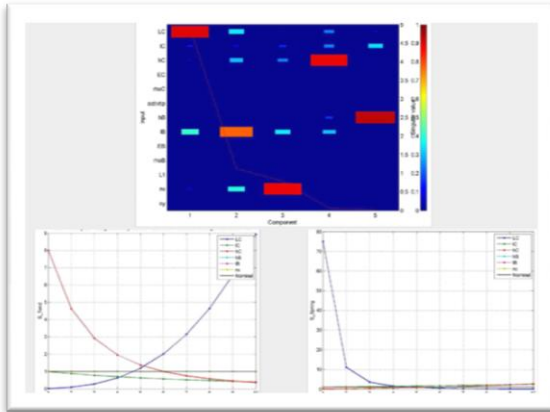
AFM Array Design Variables

Description	Initial value	Bound
Lever length	200 μm	[60 400] μm
Lever width	40 μm	[40 80] μm
Lever thickness	0.5 μm	[0.25 0.70] μm
Young modulus of lever	335Gpa	fixed
Mass density of lever	3100kg/m ³	fixed
Tip presence	1 (or 0)	fixed
Base thickness	30 μm	[30 60] μm
Base width	40 μm	[10 200] μm
Young modulus of Base	169Gpa	fixed
Mass density of Base	2330kg/m ³	fixed
Array size in x -direction	1000 μm	fixed
No. levers in x -direction	10	[2 20]
No. levers in y -direction	1	fixed
Tip base width	$x_2 - 10\mu\text{m}$	dependent
position of tip apex	$x_2/2$	dependent
Array size	$1 \times 1\text{mm}^2$	fixed
Array dimension	1 (or 2)	fixed
x -direction pitch	$\text{floor}(\frac{x_{11}}{x_{12} \times 50}) \times 50\mu\text{m}$	proportional to 50 μm
y -direction pitch	$\text{floor}(\frac{x_{11}}{x_{12} \times 50} + 1) \times 50\mu\text{m}$	proportional to 50 μm
Longitudinal base width	40 μm	[10 200] μm

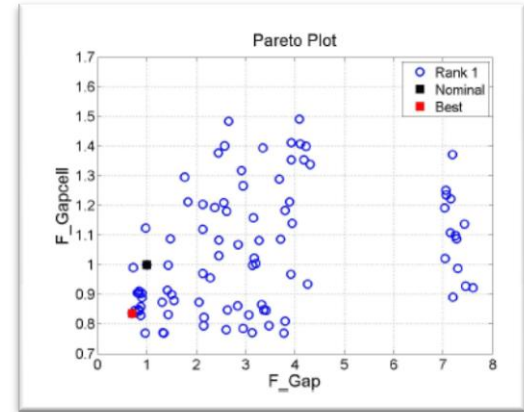
AFM Array Design objectives and constraints

Description	Equation
Maximum deflection angle at tip end less than 3/180*pi	$\frac{3S_2}{2x_1} - \frac{3\pi}{180} \leq 0$
Maximum displacement at base must smaller than 50nm for small array and 80nm for large array	$s_3 - 50\text{nm} \leq 0$ or $s_3 - 80\text{nm} \leq 0$
Minimum gap between two levers larger than 1C/2	$\frac{1C}{2} - s_4 \leq 0$
Minimum gap percentage of each cell greater than 40%	$0.4 - s_5 \leq 0$
Number of levers in x -direction more than 2	$2 - s_6 \leq 0$
Number of levers in y -direction more than 2	$2 - s_7 \leq 0$
Maximum footprint size of small and large array	$s_9 - 1 \times 1\text{mm}^2 \leq 0$ or $s_9 - 2 \times 2\text{mm}^2 \leq 0$

Sensitivity Analysis



Multi-Objective Design Optimization

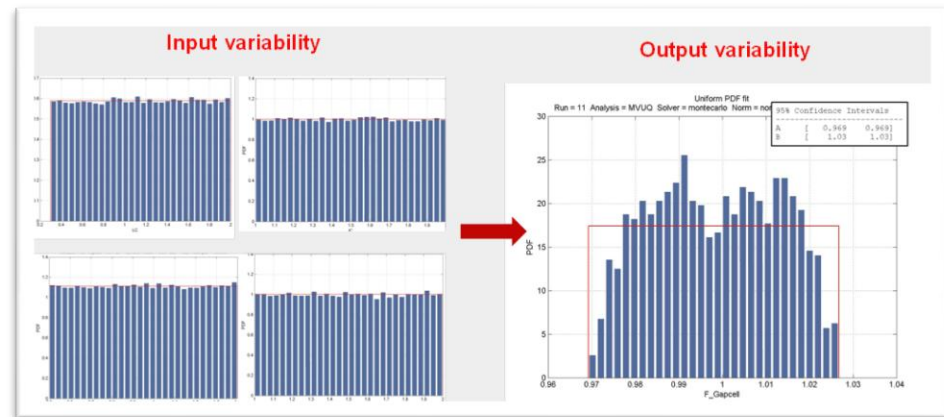


Design Optimization

Mono-objective Design Optimization



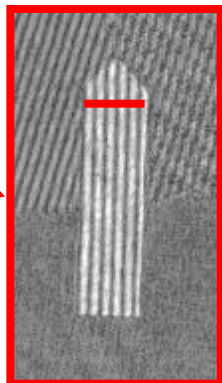
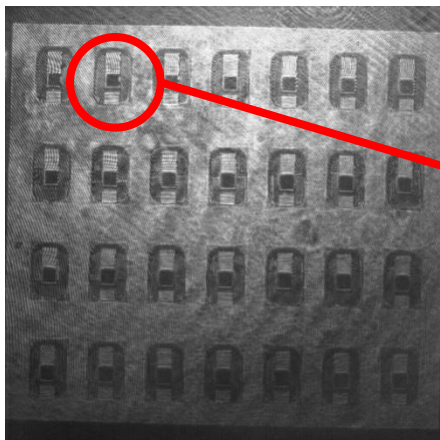
Uncertainty Quantification



- ❑ Two-scale Modelling (AFMALab Software)
- ❑ Robust Parameter Optimization (SIMBAD Software)
- ❑ **Image Processing for Interferometry**
- ❑ Semi-Decentralized Distributed Control

Image 1024 pixels x 1024 pixels

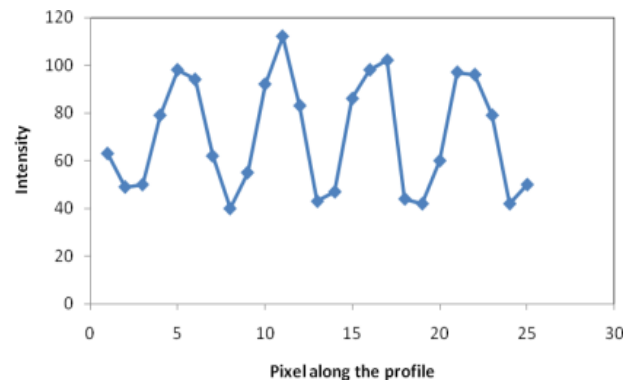
Less than 25 pixels in the width



Intensity Profile



Intensity measurement



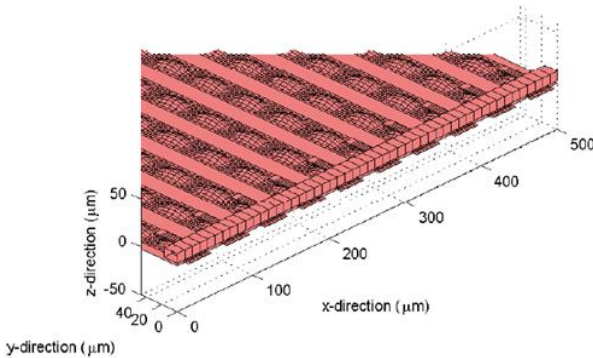
Processing
(patent pending)



Standard deviation for displacement in air in static regime:

Free lever: 0.27 nm

In contact: 1.4 nm



Sample topography $z_{obj}(i)$

Static Regime

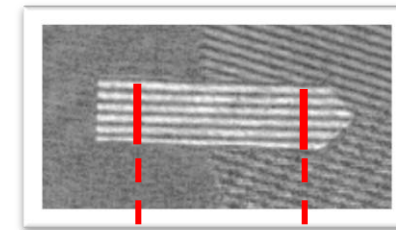
$u^{tip}(i)$

Intensity: $I(t, x_1, y_2) = A \cos(2\pi f x_1 + \theta(t, y_2))$

with $\theta = \frac{2\pi}{\lambda}(b - 2u)$

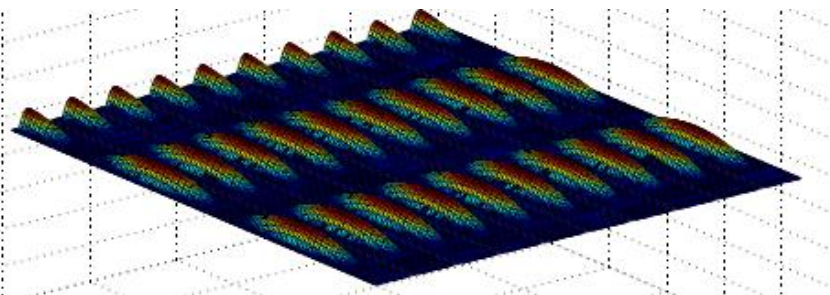
carrier wave phase

2 lines of measurements



$y_2^{0,1}$ $y_2^{0,2}$

Least square algorithm θ^*



$z_{obj}^{est}(i)$

All displacements

Model

All tip forces:

$$f_3 = - \frac{\bar{\lambda} \delta \theta}{2\pi (K(y_2^{0,2}) - K(y_2^{0,1}))}$$

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Standard State formulation for the H-infinity filter of the distributed pb:

State variable: $u = (\bar{u}, (\tilde{u}_k)_{k=1,\dots,N}, \partial_t \bar{u}, (\partial_t \tilde{u}_k)_{k=1,\dots,N})^T$

State equation: $\partial_t u(t) = Au(t) + Bw_1(t), \quad u(0) = u_0,$

Observation: $y(t) = Cu(t) + Dw_2(t),$

Estimated state: $z(t) = Lu(t).$

Observation

$$Cu(t) = \frac{1}{|\beta - \alpha|} \int_{\alpha}^{\beta} u(x_1, y_2) dy_2$$

H-infinity problem:

$$\min_{\gamma} \max_{w_1, w_2} \frac{\|z - \hat{z}\|^2}{\|w_1\|^2 + \|w_2\|^2}$$

Standard State formulation for the H-infini filter of the distributed pb:

State variable: $u = (\bar{u}, (\tilde{u}_k)_{k=1,\dots,N}, \partial_t \bar{u}, (\partial_t \tilde{u}_k)_{k=1,\dots,N})^T$

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Observation

$$Cu(t) = \frac{1}{|\beta - \alpha|} \int_{\alpha}^{\beta} u(x_1, y_2) dy_2$$

Estimator equations

$$\begin{aligned} \partial_t \hat{u}(t) &= A\hat{u}(t) + PC^*(y(t) - C\hat{u}(t)), \\ \hat{z}(t) &= L\hat{u}(t). \end{aligned}$$

with operatorial Riccati equation

$$AP + PA^* - PC^*CP + \frac{1}{\gamma^2} PL^*LP + BB^*$$

To be computed in
real time in FPGA

Difficult because:

**P = Global
Operator**

Cauchy Integral for:

▪ Holomorphic function f in \mathbb{C}

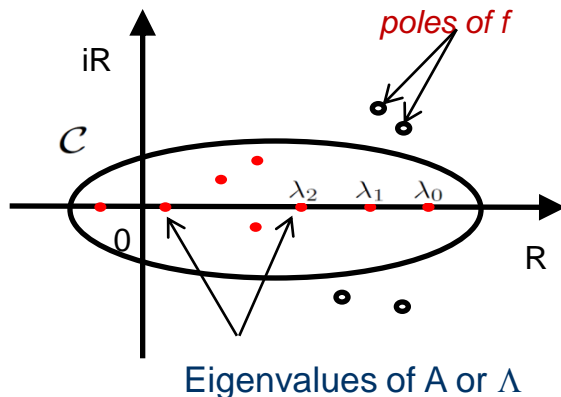
$$f(\lambda_0) = \frac{1}{2i\pi} \int_{\mathcal{C}} \frac{f(\lambda)}{\lambda - \lambda_0} d\lambda$$

▪ Function of a matrix A :

$$f(A) = \frac{1}{2i\pi} \int_{\mathcal{C}} f(\lambda)(\lambda I - A)^{-1} d\lambda$$

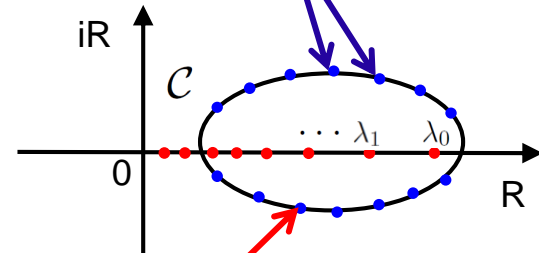
▪ Function of an operator Λ :

$$f(\Lambda) = \frac{1}{2i\pi} \int_{\mathcal{C}} f(\lambda)(\lambda I - \Lambda)^{-1} d\lambda$$



Application to PC^{N*} with $\Lambda^{-1} = \partial_{x \dots x}^4$ after a preliminary preparation of the Riccati equation:

$$PC^{N*} \approx \frac{1}{2\pi} \sum_{l=1}^M v_1^{\zeta(\theta_l)} \omega_l$$



For each ζ resolution of a 2d-system:

$$\begin{cases} \zeta_1 v_1^\zeta - \zeta_2 v_2^\zeta - \Lambda v_1^\zeta = \text{Re}(-i\zeta' k_R(\zeta)) z, \\ \zeta_2 v_1^\zeta + \zeta_1 v_2^\zeta - \Lambda v_2^\zeta = \text{Im}(-i\zeta' k_R(\zeta)) z. \end{cases}$$

Simulation of the approximated H-infinity Filter:

The plot shows "Displacement in base (m)" on the y-axis (scaled by 10^{-6}) and "Time (μs)" on the x-axis (from 0 to 1). Two signals are shown: "True outputs" (solid red line) and "Estimated outputs" (dashed blue line). Both signals show a decaying oscillatory behavior over time.

Conclusions

- Short review of our results for arrays of AFMs
- A two-scale model for the whole array sufficiently light to use in optimization procedures
- Software developed (best validated for 1D arrays)
- An optimization toolbox build and included
- Validated algorithm for interferometry with small number of pixels
- Topographic scan in static regime: recover displacements from 2 measurements and generate images for contact mode
- Dynamic regime: H-infinity filter approximation based on functional calculus

Perspectives (short term)

- Complete implementing the full setup and force spectroscopy in quasi-static regime
 - A new design based on our software is planed at CSEM
 - Verifying the H-infinity filter approximation with the observation comes from interferometry measurements
 - Implementing the full measurement chain

End

Question & Remarks